

**Search Notes**

Application/Control No.

10/796,270

Examiner

Hien N. Nguyen

Applicant(s)/Patent under  
Reexamination

WANG ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	182	11/30/2005	HN
	201		
	189.08		
	189.09		
	207		
	210		
	230.06		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
365	201	12/9/2005	HN
	189.09		
	230.06		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/30/2005	HN
(SEE Search Report)		